

Search Notes

Application/Control No.

10/645,510

Examiner

David E. Martinez

Applicant(s)/Patent under
Reexamination

TU, CHUN-YEN

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	11/22/2005	DM
710/30. 370/470-472. 709/236. 707/100. with keywords and text search	11/22/2005	DM
Inventon Search through eDan	11/22/2005	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	11/22/2005	DM